## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | PATTON ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,337,692 B1	01-2002	Rai et al.	345/594
*	В	US-6,340,994 B1	01-2002	Margulis et al.	348/625
*	С	US-5,959,672	09-1999	Sasaki, Mikio	375/240.23
*	D	US-6,678,407 B1	01-2004	Tajima, Johji	382/167
*	Е	US-6,803,948 B1	10-2004	Schmale, Peter C.	348/222.1
*	F	US-6,633,410 B1	10-2003	Narushima, Toshio	358/1.9
*	G	US-5,907,315	05-1999	Vlahos et al.	382/167
*	Н	US-6,901,162 B2	05-2005	Kagawa et al.	382/162
*	-	US-6,262,778 B1	07-2001	Nonweiler et al.	348/586
*	J	US-6,496,280 B2	12-2002	Ishikawa et al.	358/1.9
*	ĸ	US-7,079,270 B2	07-2006	Kiyosu et al.	358/1.15
*	L	US-2002/0105661	08-2002	Nishida, Hiroshi	358/1.9
*	М	US-6,434,266 B1	08-2002	Kanno et al.	382/162

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	Т					

## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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